

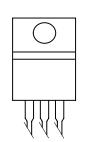
Surface Mount - 400V - 800V > MAC210A8, MAC210A10

### MAC210A8, MAC210A10



#### **Pin Out**

# 4 TO-220AB CASE 221A STYLE 4



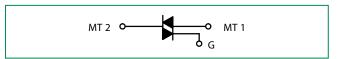
#### Description

Designed primarily for full-wave AC control applications, such as light dimmers, motor controls, heating controls and power supplies; or wherever full-wave silicon gate controlled solid-state devices are needed. Triac type thyristors switch from a blocking to a conducting state for either polarity of applied main terminal voltage with positive or negative gate triggering.

#### Features

- Blocking Voltage to 600 Volts
- All Diffused and Glass Passivated Junctions for Greater Parameter Uniformity and Stability
- Small, Rugged, Thermowatt Construction for Low Thermal Resistance, High Heat Dissipation and Durability
- Gate Triggering Guaranteed in Four Modes (Quadrants)
- Pb-Free Packages are Available

#### **Functional Diagram**



#### Additional Information







PO

Samples



#### **Maximum Ratings** ( $T_{J} = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1) (– 40 to 125°C, Sine Wave, 50 to 60 Hz, Gate Open) MAC210A8 MAC210A10	V <sub>drm</sub> , V <sub>rrm</sub>	600 800	V
On-State RMS Current (Full Cycle Sine Wave, 50 to 60 Hz, $T_c = 70^{\circ}$ C)	I <sub>T (RMS)</sub>	10	A
Peak Non-Repetitive Surge Current (One Full Cycle Sine Wave, 60 Hz, $T_c = +25^{\circ}$ C) Preceded and followed by rated current	I <sub>TSM</sub>	100	A
Circuit Fusing Consideration (t = 8.3 ms)	l²t	40	A <sup>2</sup> sec
Peak Gate Power ( $T_c = +80^{\circ}C$ , Pulse Width = 1.0 µs)	P <sub>GM</sub>	20	W
Average Gate Power (t = 8.3 ms, $T_c = 80^{\circ}C$ )	P <sub>g (AV)</sub>	0.35	W
Peak Gate Current ( $T_c = +70^{\circ}$ C, Pulse Width = 10 s)	I <sub>GM</sub>	2.0	А
Operating Junction Temperature Range	Tj	-40 to +125	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to +150	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

#### **Thermal Characteristics**

Rating		Symbol	Value	Unit
Thermal Resistance,	Junction-to-Case (AC) Junction-to-Ambient	R <sub>sjc</sub> R <sub>sja</sub>	2.0 62.5	°C/W
Maximum Lead Temperature for Sol 10 seconds	TL	260	°C	



#### **Electrical Characteristics** - **OFF** ( $T_1 = 25^{\circ}$ C unless otherwise noted ; Electricals apply in both directions)

Characteristic		Symbol	Min	Тур	Max	Unit
Peak Repetitive Blocking Current	$T_J = 25^{\circ}C$	I <sub>DRM</sub> ,	-	-	10	μA
$(V_{D} = V_{DRM} = V_{RRM}; Gate Open)$	T <sub>J</sub> = 125°C	I <sub>RRM</sub>	-	-	2.0	mA

#### **Electrical Characteristics** · **ON** ( $T_1 = 25^{\circ}C$ unless otherwise noted; Electricals apply in both directions)

Characteristic			Min	Тур	Max	Unit
Peak On–State Voltage (TM = 14 A Peak; Pulse Width = 1 to 2 ms, Duty Cycle 2%)			-	_	1.6	V
	MT2(+), G(+)		-	12	50	
Gate Trigger Current (Continuous dc) (V <sub>D</sub> = 12 V, R <sub>L</sub> = 100 Ohms)	MT2(+), G(-)		-	12	50	mA
	MT2(–), G(–)	GT I <sub>GT</sub>	-	20	50	IIIA
	MT2(-), G(+)	1	-	35	75	
	MT2(+), G(+)		-	0.9	2.0	
Gate Trigger Voltage	MT2(+), G(–) MT2(–), G(–)		-	0.9	2.0	V
(Continuous dc) ( $V_{\rm D}$ = 12 V, R <sub>L</sub> = 100 $\Omega$ )		-	1.1	2.0	V	
	MT2(-), G(+)		-	1.4	2.5	
Holding Current (V <sub>D</sub> = 12 V <sub>dc</sub> , Gate Open, Initiating Current = $\pm$ 150 mA))			-	6.0	50	mA
Turn-On Time (Rated $V_{DRM}$ , $I_{TM}$ = 14 A) ( $I_{GT}$ = 120 mA, Rise Time = 0.1 s, Pulse Width = 2 s)		t <sub>gt</sub>	_	1.5	_	μs

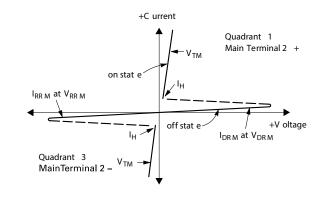
Dynamic Characteristics						
Characteristic	Symbol	Min	Тур	Max	Unit	
Critical Rate of Rise of Commutation Voltage ( $V_D = Rated V_{DRM}$ , $I_{TM} = 14 A$ , Commutating di/dt = 5.0 A/ms, Gate Unenergized, TC = 70°C)	(di/dt)c	_	5.0	_	A/ms	
Critical Rate of Rise of Off-State Voltage ( $V_{D}$ = Rated $V_{DRM'}$ Exponential Waveform, Gate Open, $T_{C}$ = +70°C)	dv/dt	_	100	-	V/µs	



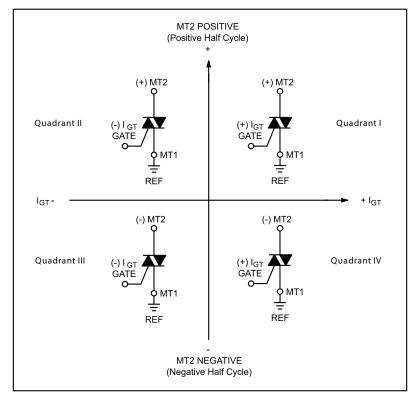
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#### **Voltage Current Characteristic of SCR**

Symbol	Parameter
V <sub>drm</sub>	Peak Repetitive Forward Off State Voltage
I <sub>DRM</sub>	Peak Forward Blocking Current
V <sub>RRM</sub>	Peak Repetitive Reverse Off State Voltage
I <sub>RRM</sub>	Peak Reverse Blocking Current
V <sub>TM</sub>	Maximum On State Voltage
I <sub>H</sub>	Holding Current



#### **Quadrant Definitions for a Triac**



All polarities are referenced to MT1.

With in-phase signals (using standard AC lines) quadrants I and III are used.



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#### Figure 1. Current Derating

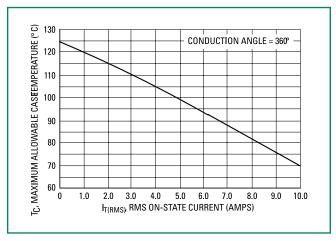
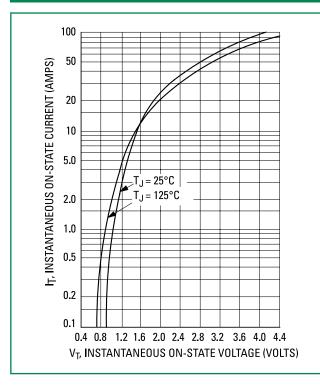
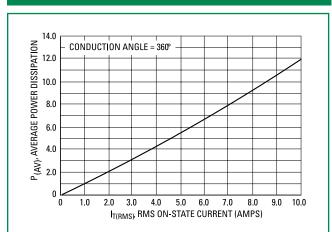


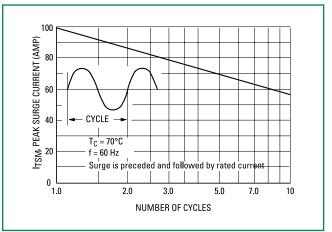
Figure 3. Maximum On–State Characteristics



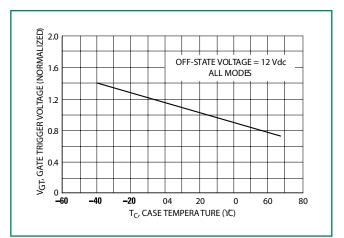
#### Figure 2. Power Dissipation



#### Figure 4. Maximum Non-Repetitive Surge Current



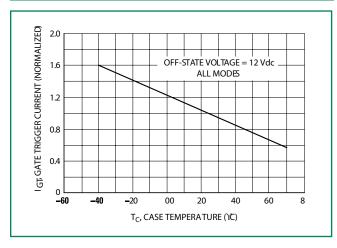
#### Figure 5. Typical Gate Trigger Voltage



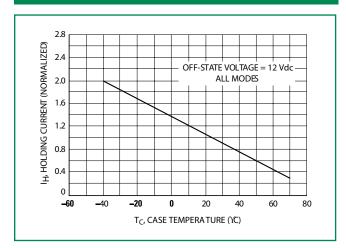


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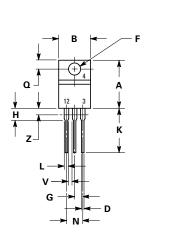
### Figure 7. Typical Holding Current

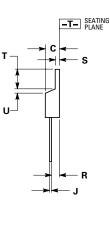




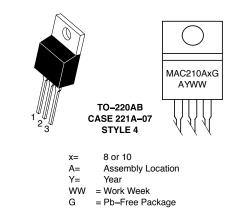
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#### Dimensions





#### Part Marking System



Pin Assignment	
1	Main Terminal 1
2	Main Terminal 2
3	Gate
4	Main Terminal 2

#### **Ordering Information**

Device	Package	Shipping
MAC210A8	TO-220AB	
MAC210A8G	TO-220AB (Pb-Free)	500
MAC210A10	TO-220AB	Units/ Box
MAC210A10G	TO-220AB (Pb-Free)	

	Inc	hes	Millim	neters
Dim	Min	Max	Min	Max
А	0.590	0.620	14.99	15.75
В	0.380	0.420	9.65	10.67
С	0.178	0.188	4.52	4.78
D	0.025	0.035	0.64	0.89
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.41	2.67
Н	0.110	0.130	2.79	3.30
J	0.018	0.024	0.46	0.61
К	0.540	0.575	13.72	14.61
L	0.060	0.075	1.52	1.91
Ν	0.195	0.205	4.95	5.21
Q	0.105	0.115	2.67	2.92
R	0.085	0.095	2.16	2.41
S	0.045	0.060	1.14	1.52
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045		1.15	
Z		0.080		2.04

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

2. CONTROLLING DIMENSION: INCH.

3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

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